NO:



TO:

Halogen Free Part

SPECIFICATION FOR APPROVAL

DESCRIPTION: 0.5mm M.2 H4.2 B-KEY; HF

CUSTOMER P/N:

LOTES P/N: APCI0105-P001A

CUSTOMER APPROVAL SIGN:

SEND BY	QA CONFIRM	R&D CONFIRM	PREPARE BY
		Ford	Jinjin Tu







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LOTES CO., LTD

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REV	ECN No.
1B	SN14***

DIMENSION

1. This specification covers M.2 connector.

2. The physical dimensions and the M.2 connector are shown in drawing.

MATERIAL AND FINISH

1. Housing: High temperature thermoplastic, Color: Black;

2. Contact: Copper Alloy, 50-120u" Nickel under plated, Au on contact area, Au on soldering area;

3. SMT TAB: S50C, 50-120u"Nickel under plated, plating Tin (Matte)80-180u" over all;

OPERATING PERFORMANCE

1.Operation Temperature: -55°C to 85°C

2. Voltage Rating: 30V3. Current Rating: 0.5A

ELECTRICAL PERFORMANCE

Test item	Test condition	Requirements
Examination of product	Visual inspection	No physical damage
Low Level Contact Resistance	EIA-364-23 Mate connectors: apply a current of 10mA(Max) at open circuit voltage of 20mVvoltage(Max)	• Initial $55m\Omega$ Max. • Final \triangle LLCR = $20m\Omega$ Max.
Insulation resistance	Applying 500VDC for one minute between adjacent contacts of unmated connectors EIA-364-21	• 500MΩ Min.
Dielectric withstanding voltage	Measured by applying 300V/AC for one minute between adjacent contacts of unmated connector assemblies. EIA-364-20	No breakdown or flashCurrent leakage: 0.5 mA
Temperature rise versus current	• The temperature rise above ambient shall not exceed 30°C .the ambient condition is still air at 25°C . EIA-364-70 Method 2	 No physical damage △ T=30°C Max.

	PRODUCT NAME: M.2 CONNECTOR				
LOTES CO., LTD	DOCUMENT No: SP-APCI00		REV: 1B		PAGE: 1 OF 5
LOTES CO., LTD	APPROVED BY: Barney	CHECKE Vite			RITTEN BY: AN ZHI WU

REV ECN No.

1B SN14***

MECHANICAL PERFORMANCE

Test item	Test condition	Requirements
• EIA-364-28, test condition VII, test condition letter D(15 minutes in each of 3 mutually perpendicular directions. Both mating halves should be rigidly fixed so as not to contribute to the relative motion of one contact against another. The method of fixturing should be detailed in the test report)		 No electrical discontinuity greater than 1 microsecond. △LLCR=20mΩ Max.(Final)
Mechanical shock	250 G (Ultra-book) and 285 G (Tablet) at 2m Sec half sine on all six axis	 No electrical discontinuity greater than 1 microsecond Δ LLCR=20mΩ Max.(Final) No physical damage
Insertion/Removal Force	• Insertion Force-20 N (2.04 kgf) Max. Removal Force-Typical 20 N, 25 N (2.55 kgf) Max. EIA-364-13	No evidence of physical damage
Durability (precondition)	 EIA-364-09 Perform 5 unplug /plug cycles if the application requires up to 25 over the life of the connector, 20 cycles if the application requires 26-200; 	No evidence of physical damage
 Option1:Repeat insertion the Card to the connector and extraction Card from the connector for 25 cycles(Au:30u"Max). Option2:Repeat insertion the Card to the connector and extraction Card from the connector for 60 cycles(Au:30u"Min). EIA-364-09 		• △LLCR=20mΩ Max.(Final)
Reseating	Manually unplug/plug the connector or socket perform 3 cycles	No evidence of physical damage

TITLE: M.2 CONNECTOR							
	DOCUMENT No: SP-APCIO	0018	REV: 1B		PAGE: 2 OF 5		
LOTES CO., LTD	APPROVED BY:	CHECKED BY:		WRITTEN BY:			
	Barney	Vite	0	T	AN ZHI WU		

REV ECN No.
1B SN14***

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п,	1 N	vik		/		PRRIVIANUE

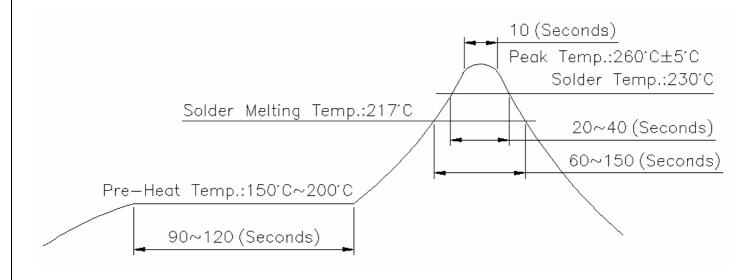
Test item	Test condition	Requirements
Cyclic temperature &Humidity	• EIA-364-31 method III without conditioning, initial measurements, cold shock and vibration. (Except cycle the connector or socket between 25°C±3°C at 80% ± 3% RH and 65°C±3°C at 50% ± 3% RH. Ramp times should be 0.5 hour and dwell times should be 1.0 hour. Dwell times start when the temperature and humidity have stabilized within the specified levels. Perform 24 such cycles.) • EIA-364-31	 Contact resistance:
Thermal shock	• EIA-364-32,method A,test condition I,test duration A-4 Cold extreme :-55°C+0/-5°C Hot extreme :85°C+3/-0°C each temperature dwell 2 hour, perform 10 cycles in mated condition.	 Contact resistance:
Salt spray	• Subject the connector to 5% salt-solution concentration at $35^\circ\!$	 Contact resistance:
Temperature life	• Mate PCB module and subject to 105±2°C for 120 hours EIA-364-17	 Contact resistance: \(\triangle LLCR = 20m\Omega Max.(Final) \) No physical damage.
Temperature life (preconditioning)	• Mate PCB module and subject to 105±2°C for 72 hours EIA 364-17 method A, using table 9 for reference	 Contact resistance:
Resistance to Reflow Soldering Heat	• Test connector on PCB • Pre-Heat :100~150°C • Heat : 210°C • Heat Peak : 260+5°C/-0°C,10+/-1s	No physical damage
Solder ability	 Solder Temperature :245±5°C Solder time : 3±0.5s 	• Wet solder coverage: 95% Min.
Rework temperature	• 350°C,3-5seconds for "solder iron-Max.", temperature of component by rework process.	No Damage
Mixed flowing gas	 EIA-364-65, Environmental Class – IIA For 7days, Connectors should be mated during this portion of the test. Total Mixed flowing gas exposure 168 hours, include unmated exposure 112 hours and mated exposure 56 hours. 	 No discontinuations of microsecon or longer duration Contact resistance: ΔLLCR=20mΩ Max. (Final)
Chermal disturbance	• Cycle the mated connector between 15°C±3°C and 85°C±3°C, as measured on the part. Ramps should be a minimum of 2°C per minute, and dwell times should insure that the contacts reach the temperature extremes(a minimum of 5 minutes). Humidity is not controlled. Perform 10 such cycles.	 No evidence of physical damage Contact resistance: ΔLLCR=20mΩ Max. (Final)

	TITLE:					
	M.2 CONNECTOR					
	DOCUMENT No:		REV:		PAGE:	
	SP-APCI0	1B		3 OF 5		
LOTES CO., LTD						
	APPROVED BY:	CHECKE	ZD BY:	WR	RITTEN BY:	
	Barney	Vit	0	T	AN ZHI WU	

REV	ECN No.
1B	SN14***

LOTES RECOMMENDED LEAD FREE SMT TEMPERATURE PROFILE

Suggestion: In SMT process, the thickness of solder paste is 0.13mm minimum



PACKAGE

All parts shall be packaged and packed to protect against physical damage, corrosion and deterioration during shipment and storage.

	PRODUCT NAM	E :			
		M.2 CON	NECTOR		
	DOCUMENT No	•	REV:		PAGE:
	SP-APCI	1B		4 OF 5	
LOTES CO., LTD					
	APPROVED BY:	CHECKE	D BY:	WR	RITTEN BY:
	Barney	Vite	0	T	AN ZHI WU

REV	ECN No.
1B	SN14***

Test conditions

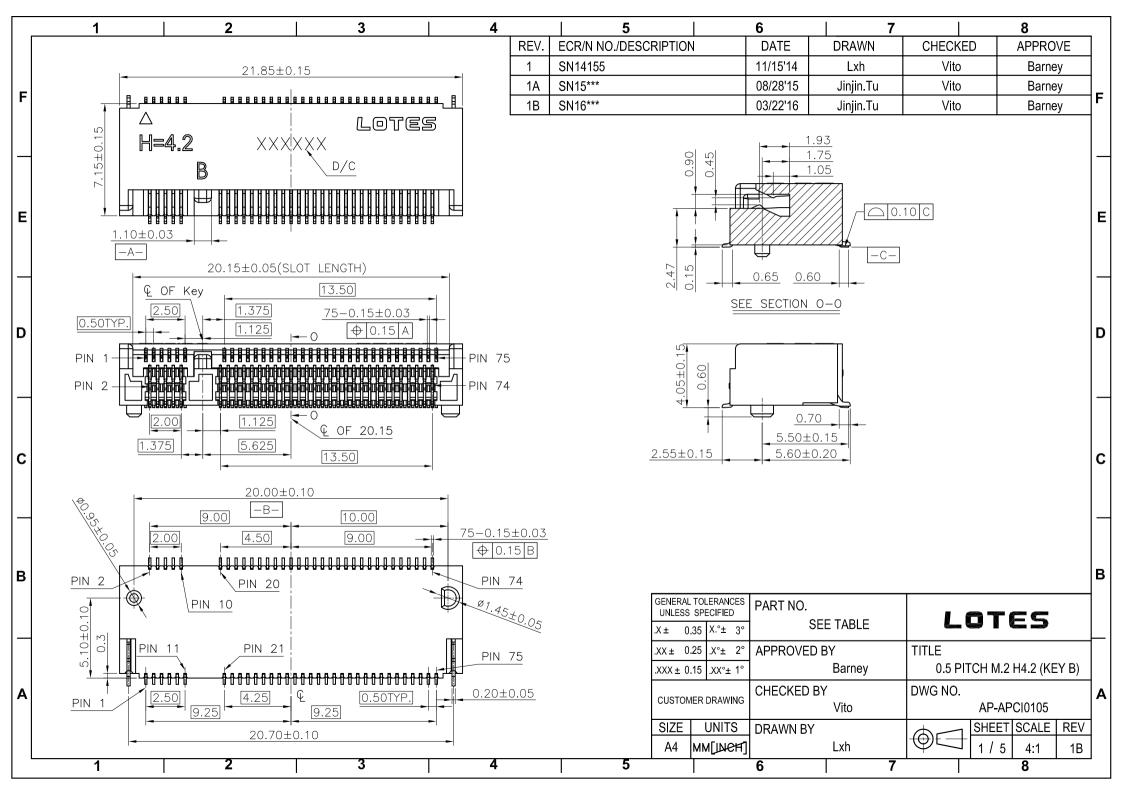
The tests shall be carried out under the conditions as the referring.0

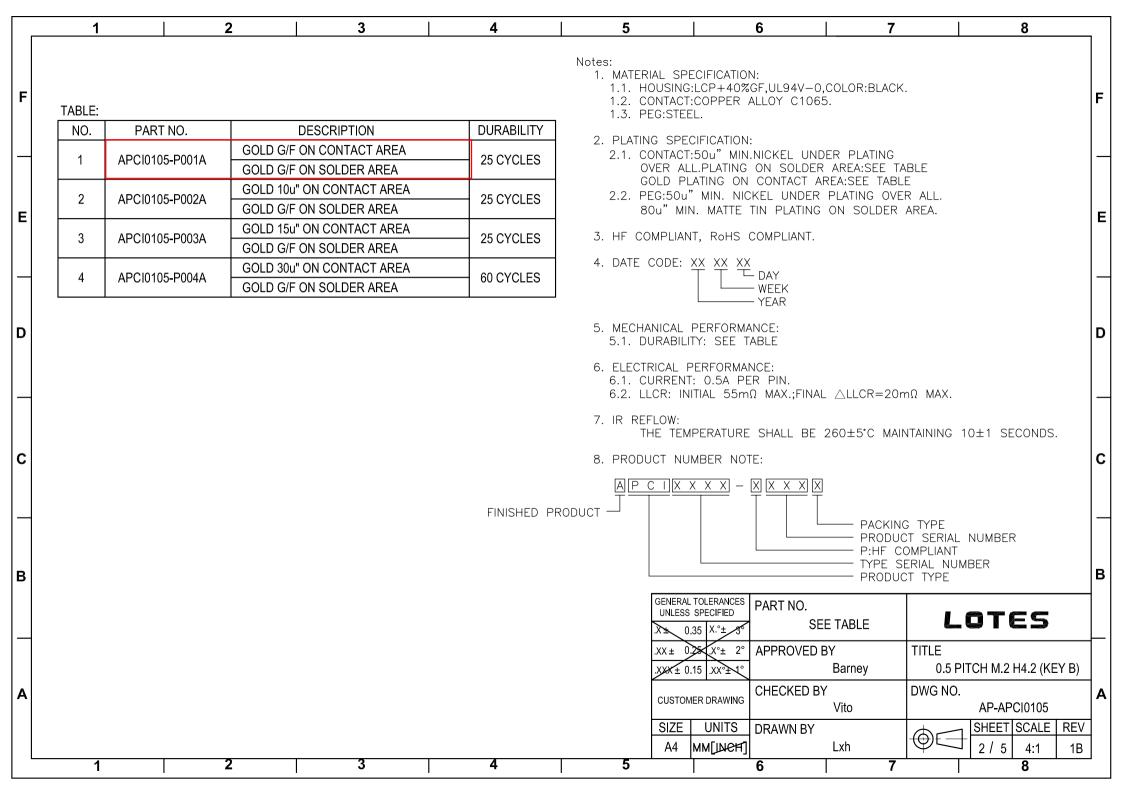
(1).Temperature:15~35°C. (2).Humidity: 45~75%

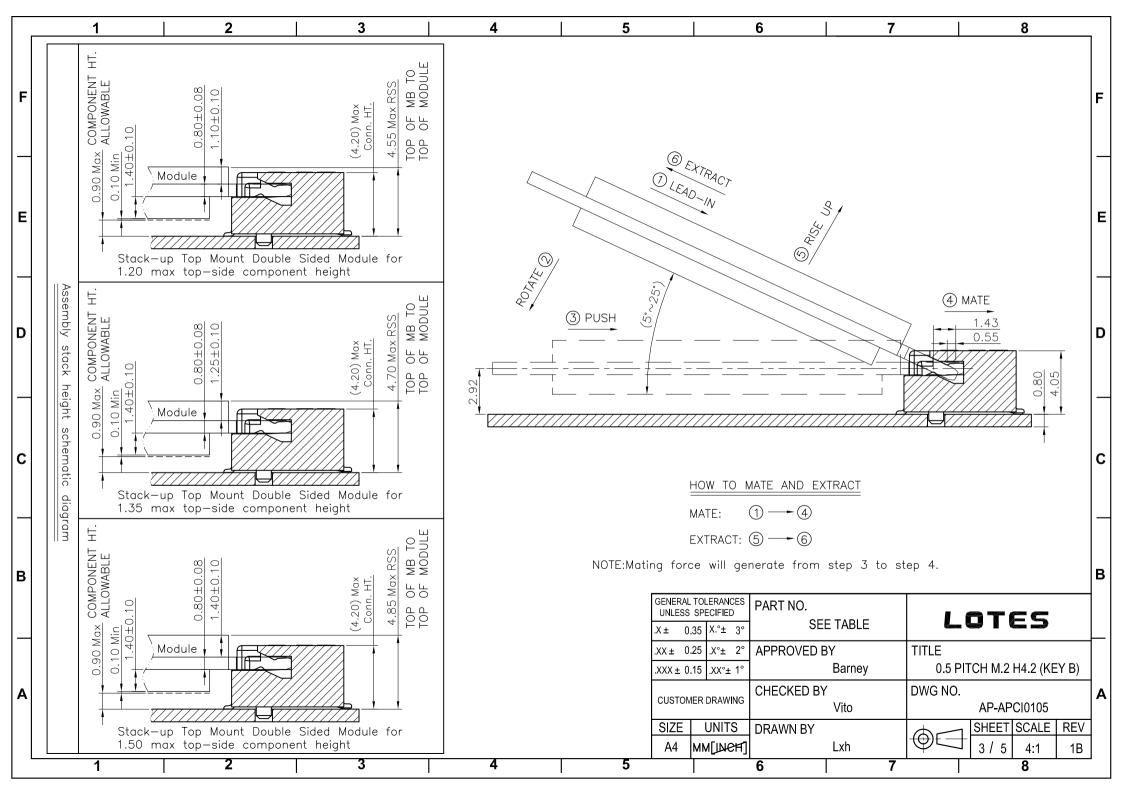
Test Sequence:

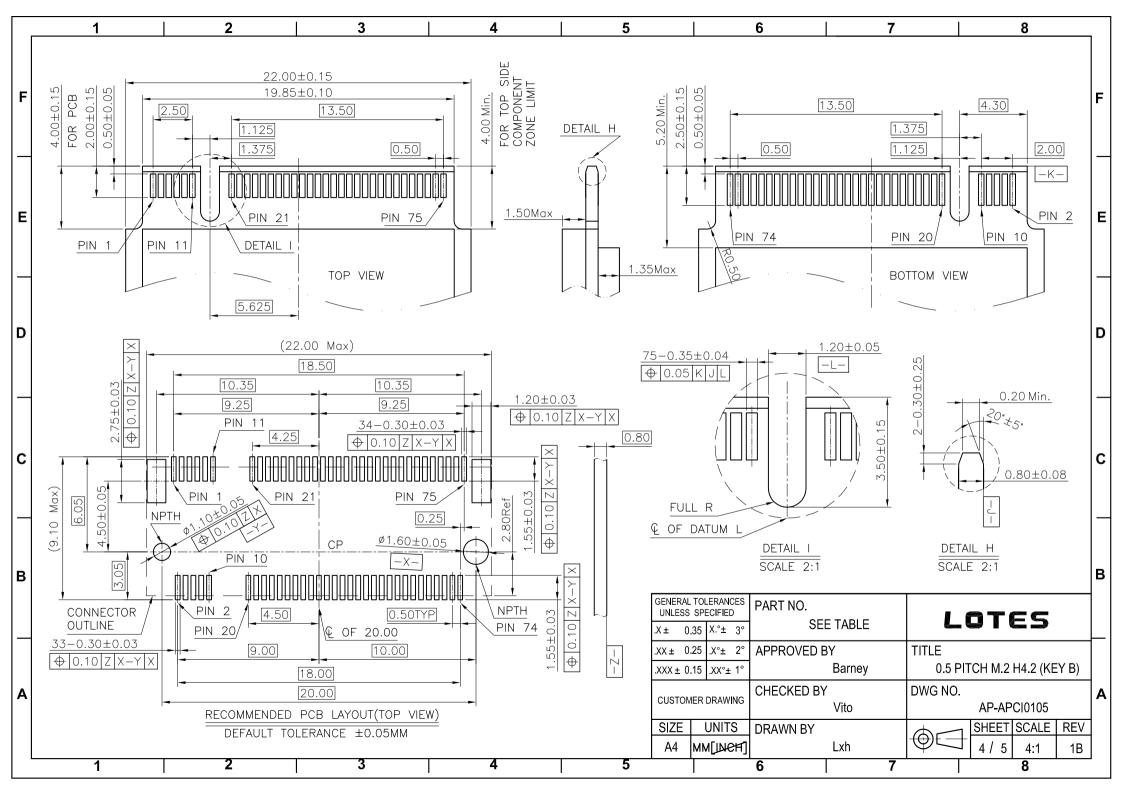
equence.						
Task an Emandination			Test G	roup		
Test or Examination	А	В	С	D	Е	F
Examination of Product	1,8	1,10	1,10	1,10	1,4	1
Low Level Contact Resistance	2,5,7	2,5,7,9	2,5,7,9	2,6,9		
Dielectric Withstanding Voltage					2	
Insulation Resistance					3	
Temperature versus current						2
Vibration			6			
Mechanical shock			8			
Insertion/Removal Force				3,5,8		
Durability (precondition)	3	3	3			
Durability				4,7		
Thermal Shock		4				
Cyclic temperature(Humidity)		6				
Mixed flowing gas						
Reseating	6	8				
Thermal disturbance						
Temperature life	4					
Temperature life (Preconditioning)			4			
Specimen quantity (pcs)	5	5	5	5	5	5

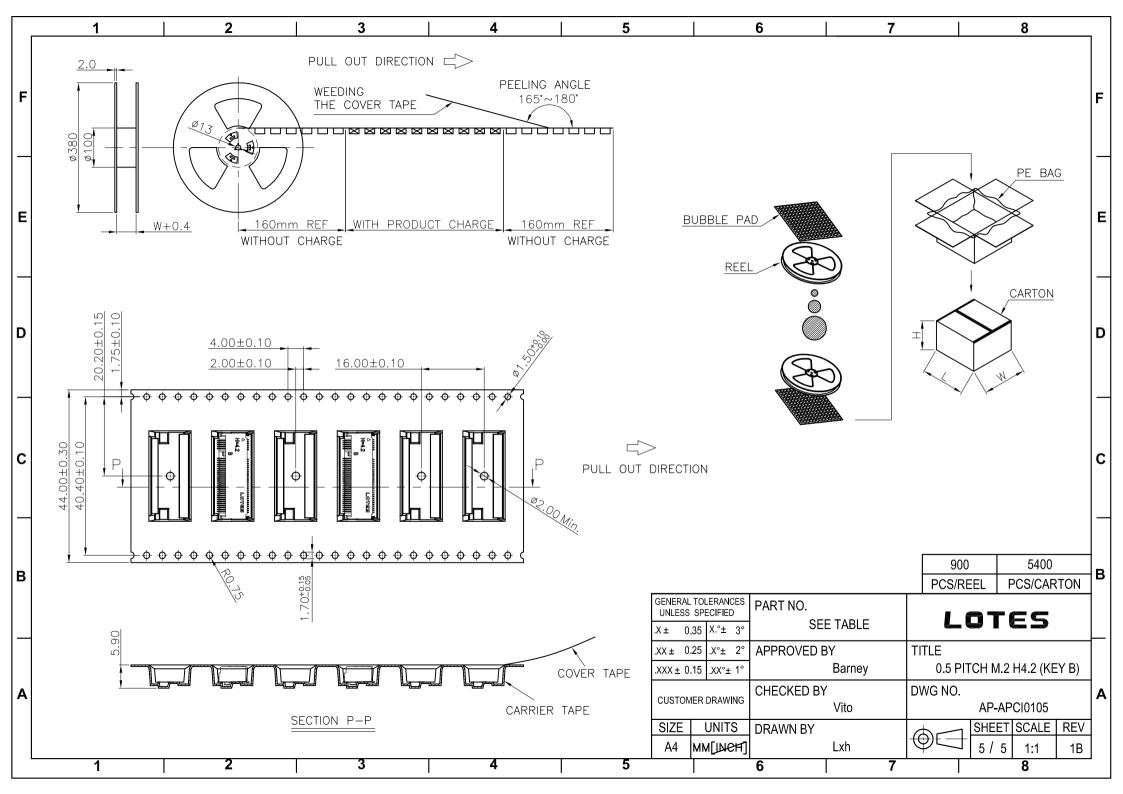
LOTES CO., LTD		PROI	PRODUCT NAME: M.2 CONNECTOR							
	DOC	DOCUMENT No: SP-APCI0018			3	PAGE: 5 OF 5				
	LOTES CO., LTD	APPR	APPROVED BY: CHECKI				RITTEN BY:			
				Barney	Vi	Vito		TAN ZHI WU		











ReportNo:GL-SZ20140304-01

 ${\tt product:NGFF~4.2H~B\!-\!Key~CONNECTOR}$

Part NO:APCI0105-P00*A

Test Object:Product Reliability Test

Sample Quantity: 40pcs

Test Environment: 20~22°C; 50~54%RH

Date of Test: 2014-03-06~2014-05-16

Prepared By:覃庭 Checked By:苏士坤 Approved By:周志奇

Test Result Summary:

Qualification Group	Pass / Fail	Comments
groupA	Qualified	
groupB	Qualified	
groupC	Qualified	
groupD	Qualified	
groupE	Qualified	
groupF	Qualified	



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GL-P-027-005

1. Testing Sequence:

	Testing Sequence.			Test	Group		
	Test or Examination	A	В	С	D	Е	F
1	Examination of Product	1,8	1,10	1,10	1,10	1,4	1
2	Low Level Contact Resistance	2,5,7	2,5,7,9	2,5,7,9	2,6,9		
3	Dielectric Withstanding Voltage					2	
4	Insulation Resistance					3	
5	Temperature versus current						2
6	Vibration			6			
7	Mechanical shock			8			
8	Insertion/Removal Force				3,5,8		
9	Durability (precondition)	3	3	3			
10	Durability				4,7		
11	Thermal Shock		4				
12	Cyclic temperature(Humidity)		6				
13	Reseating	6	8				
14	Temperature life	4					
15	Temperature life (Preconditioning)			4			
16	Specimen quantity (pcs)	5	5	5	5	5	5



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2. Test Item & Condition & Requirements:

]	PROCEDURES	CONDITIONS	REQUIREMENTS
1	Examination of product	Visual inspection	No physical damage
2	Low Level Contact Resistance	EIA-364-23 Mate connectors: apply a current of 10mA(Max) at open circuit voltage of 20mVvoltage(Max)	Initial $55\text{m}\Omega$ Max. Final \triangle LLCR = $20\text{m}\Omega$ Max.
3	Dielectric withstanding voltage	Measured by applying 300V/AC for one minute between adjacent contacts of unmated connector assemblies.	No breakdown or flash Current leakage: 0.5 mA
4	Insulation resistance	Applying 500VDC for one minute between adjacent contacts of unmated connectors EIA-364-21	500MΩ Min.
5	Temperature rise versus current	The temperature rise above ambient shall not exceed 30° C .the ambient condition is still air at 25° C .EIA-364-70 Method 2	No physical damage △ T=30°C Max.
6	EIA-364-28, test condition VII, test condition letter D(15 minutes in each of 3 mutually perpendicular directions. Both mating halves should be rigidly fixed so as not to contribute to the relative motion of one contact against another. The method of fixturing should be detailed in the test report)		No electrical discontinuity greater than 1 microsecond. ΔLLCR=20mΩ Max.(Final)
7	Mechanical shock	250 G (Ultra-book) and 285 G (Tablet) at 2m Sec half sine on all six axis	No electrical discontinuity greater than 1 microsecond Δ LLCR=20mΩ Max.(Final) No physical damage
8	Insertion/Removal Force	Insertion Force-20 N (2.04 kgf) Max. Removal Force-Typical 20 N, 25 N (2.55 kgf) Max. EIA-364-13	No evidence of physical damage
9	Durability (precondition) Durability (precondition) Durability (precondition) Perform 5 unplug /plug cycles if the application requires up to 25 over the life of the connector, 20 cycles if the application requires 26-200;		No evidence of physical damage
10	Durability	Option1: Repeat insertion the Card to the connector and extraction Card from the connector for 25 cycles(Au:30u"Max). Option2: Repeat insertion the Card to the connector and extraction Card from the connector for 60 cycles(Au:30u"Min). EIA-364-09	△LLCR=20mΩ Max.(Final)



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]	PROCEDURES	CONDITIONS	REQUIREMENTS
11	Thermal shock	EIA-364-32,method A,test condition I,test duration A-4 Cold extreme :-55°C+0/-5°C Hot extreme :85°C+3/-0°C each temperature dwell 2 hour, perform 10 cycles in mated condition.	Contact resistance: $\triangle LLCR=20m\Omega$ Max.(Final) No physical damage.
12	EIA-364-31 method III without conditioning, initial measurements, cold shock and vibration (Except cycle the connector or socket between 25°C±3°C at 80% ± 3% RH and 65°C±3°C at 50% ± 3% RH. Ramp times should be 0.5 hou and dwell times should be 1.0 hour. Dwell times start when the temperature and humidity have stabilized within the specified levels. Perform 24 such cycles.) • Manually unplug/plug the connector or socket perform 3 cycles		Contact resistance: $\triangle LLCR = 20m\Omega \ Max.$ Insulation resistance: $500M\Omega$ Min.No physical damage.
13	Reseating	, , , , ,	No evidence of physical damage
14	Thermal disturbance	•Cycle the mated connector between 15°C±3°C and 85°C±3°C, as measured on the part. Ramps should be a minimum of 2°C per minute, and dwell times should insure that the contacts reach the temperature extremes(a minimum of 5 minutes). Humidity is not controlled. Perform 10 such cycles.	No evidence of physical damage Contact resistance: ΔLLCR=20mΩ Max. (Final)
15	Temperature life	Mate PCB module and subject to 105±2℃ for 120 hours EIA-364-17	Contact resistance:
16	Temperature life (preconditioning)	Mate PCB module and subject to 105±2°C for 72 hours EIA 364-17 method A, using table 9 for reference	Contact resistance: $\triangle LLCR=20m\Omega$ Max.(Final) No physical damage.



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3. Testing Result:

Group A:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	LLCR	25. 21	27. 09	29. 35	26. 41	26. 73	mΩ	Pass
3	Durability (Preconditioning)	Normal	Normal	Normal	Normal	Normal	/	Pass
4	Temperature Life	Normal	Normal	Normal	Normal	Normal	/	Pass
5	LLCR	27. 11	27. 18	27. 75	26. 25	28. 96	mΩ	Pass
3	△LLCR	4. 32	1. 77	2. 53	2. 58	4. 86	mΩ	Pass
6	Reseating	Normal	Normal	Normal	Normal	Normal	/	Pass
7	LLCR	28.06	28. 03	29. 67	27. 08	29. 17	$m\Omega$	Pass
/	△LLCR	5. 13	4. 11	2. 95	3. 70	4. 91	mΩ	Pass
8	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass



Report No. GL-SZ20140304-01

GL-P-027-005

Group B:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	LLCR	26. 13	26. 31	24. 78	26. 11	25. 71	mΩ	Pass
3	Durability(Preconditioning)	Normal	Normal	Normal	Normal	Normal	/	Pass
4	Thermal Shock	Normal	Normal	Normal	Normal	Normal	/	Pass
5	LLCR	25. 92	26. 19	25. 99	26. 70	26. 31	mΩ	Pass
3	△LLCR	3. 36	2. 91	4. 25	5. 56	2. 21	mΩ	Pass
6	Cyclic Temp & Humidity	Normal	Normal	Normal	Normal	Normal	/	Pass
7	LLCR	25. 63	25. 74	25. 36	27. 12	25. 66	mΩ	Pass
/	△LLCR	3. 04	2. 42	3. 58	5. 98	1. 90	mΩ	Pass
8	Reseating	Normal	Normal	Normal	Normal	Normal	/	Pass
9	LLCR	25. 42	25.65	25. 41	26. 18	25. 57	mΩ	Pass
9	△LLCR	2. 78	2. 69	3. 68	5. 04	1. 73	mΩ	Pass
10	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass



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Group C:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	LLCR	27. 91	30. 99	29. 37	30. 58	30. 32	mΩ	Pass
3	Durability (Preconditioning)	Normal	Normal	Normal	Normal	Normal	/	Pass
4	Temperature Life (Preconditioning)	Normal	Normal	Normal	Normal	Normal	/	Pass
5	LLCR	29. 48	30. 38	29. 77	32. 69	28.61	mΩ	Pass
3	△LLCR	6. 55	6. 69	4. 56	4. 45	3. 45	$m\Omega$	Pass
6	Vibration	Normal	Normal	Normal	Normal	Normal	/	Pass
7	LLCR	28. 57	29. 99	28. 13	28. 02	27. 43	mΩ	Pass
'	△LLCR	5. 15	5. 45	4. 78	5. 41	3. 99	mΩ	Pass
8	Mechanical shock	Normal	Normal	Normal	Normal	Normal	/	Pass
9	LLCR	29. 40	33. 77	28. 57	30. 11	28. 20	mΩ	Pass
9	△LLCR	3. 67	10.08	3. 99	5. 32	4. 24	mΩ	Pass
10	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass



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Group D:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	LLCR	25. 32	25. 67	34. 55	25. 87	26. 90	mΩ	Pass
3	Insertion Force	0. 91	0.84	0. 98	0.87	0. 94	Kgf	Pass
3	Removal Force	0.75	0. 68	0. 76	0. 68	0.80	Kgf	Pass
4	Durability	Normal	Normal	Normal	Normal	Normal	/	Pass
5	Insertion Force	0.84	0. 76	0. 75	0.88	0.81	Kgf	Pass
3	Removal Force	0.77	0.63	0. 69	0.71	0.73	Kgf	Pass
6	LLCR	28. 22	28. 83	34. 51	28. 81	27. 93	mΩ	Pass
U	△LLCR	3.88	4. 16	0. 14	5. 09	3. 56	mΩ	Pass
7	Durability	Normal	Normal	Normal	Normal	Normal	/	Pass
8	Insertion Force	0.71	0.81	0.81	0. 76	0.74	Kgf	Pass
0	Removal Force	0.68	0. 65	0. 78	0. 68	0. 68	Kgf	Pass
9	LLCR	32.81	31. 24	34. 62	29. 23	28. 07	mΩ	Pass
	△LLCR	7. 50	8. 01	0.09	5. 76	3. 61	mΩ	Pass
10	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass

Group E:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	Dielectric Withstanding Voltage	300	300	300	300	300	Vac	Pass
3	Insulation Resistance	Normal	Normal	Normal	Normal	Normal	/	Pass
4	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass



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Group F:

	Examination Step/ Item	Sample 1	Sample 2	Sample 3	Sample 4	Sample 5	Unit	Pass/Fail
1	Examination Of Product	Normal	Normal	Normal	Normal	Normal	/	Pass
2	Temperature versus current	23. 11	24. 17	24. 02	25. 07	23. 94	$^{\circ}\!\mathbb{C}$	Pass



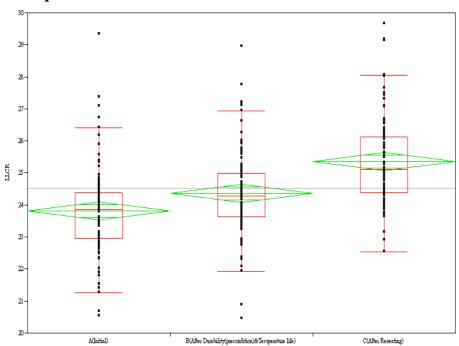
Report No. GL-SZ20140304-01

GL-P-027-005

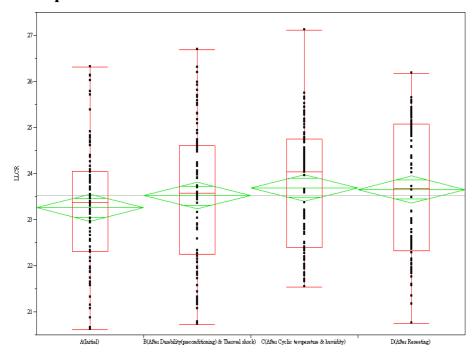
4. The LLCR Oneway analysis as follow: (Unit: $m\Omega$)



Group A:



Group B



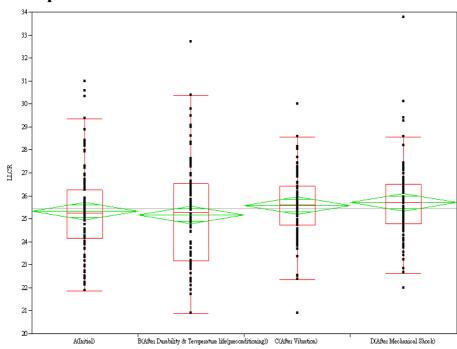
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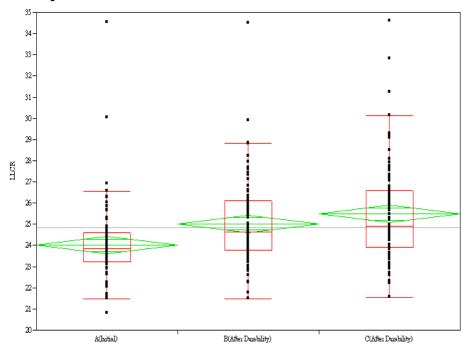
Report No. GL-SZ20140304-01

GL-P-027-005

Group C



Group D



Properties of Sumikasuper LCP SV6808THF

		ASTM	Unit	SV6808THF
Specific gravity		D792		1.72
Mold shrinkage rate	MD	Sumitomo chemical method	%	0.22
	TD	method	%	0.91
Tensile		Strength	D638	100MPa
		Elongation		4.30%
Flexural	Strength	D790	MPa	127
	Modulus		GPa	9.3
Izod impact strength	D256	J/m		590
TDUL 1.82MPa		D648	Degree C	270

- 1. The tool of 64mmX64mmX3mmt was used.
- 2. The highest temperature at which the test piece does not deform after immersing in a solder bath for 60 seconds.
- * The above physical properties data are just for reference, and are not intended for any warranty or guaranty on the materials stated in this brochure.

- End of document -

UL iQTM for Plastics 1/1 ページ

Component - Plastics E249884

SUMITOMO CHEMICAL CO LTD

ELECTRONIC MATERIALS DIV, TOKYO SUMITOMO TWIN BLDG, 27-1 SHINKAWA 2-CHOME, CHUO-KU TOKYO 104-8260 JP

SV6808THF(r5)

Liquid Crystal Polymer (LCP), "SUMIKASUPER", furnished as pellets

	Min Thk	Flame			RTI	RTI	RTI
Color	(mm)	Class	HWI	HAI	Elec	Imp	Str
NC, BK	0.3	V-0	-	-	130	130	130
	3.0	V-0	-	-	130	130	130
Comporativo	Tracking Index (CTI):			la alia.	ad Diana Trac	dring (IDT).	

Comparative Tracking Index (CTI): - Inclined Plane Tracking (IPT): -

Dielectric Strength (kV/mm): - Volume Resistivity (10^x ohm-cm) : -

High-Voltage Arc Tracking Rate (HVTR): - High Volt, Low Current Arc Resis (D495): -

Dimensional Stability (%): -

(r5) - Virgin and regrind material up to 70% by weight have the same V-0 flammability characteristics. No other properties have been evaluated for 25% - 70% regrind.

ANSI/UL 94 small-scale test data does not pertain to building materials, furnishings and related contents. ANSI/UL 94 small-scale test data is intended solely for determining the flammability of plastic materials used in the components and parts of end-product devices and appliances, where the acceptability of the combination is determined by UL.

Report Date: 2012-12-26 Last Revised: 2012-12-27

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IEC and ISO Test Methods

			Thickness	
Test Name	Test Method	Units	Tested (mm)	Value
Flammability	IEC 60695-11-10	Class (color)	0.3	V-0 (NC, BK)
			3.0	V-0 (NC, BK)
Glow-Wire Flammability (GWFI)	IEC 60695-2-12	С	-	-
Glow-Wire Ignition (GWIT)	IEC 60695-2-13	С	-	-
IEC Comparative Tracking Index	IEC 60112	Volts (Max)	-	-
IEC Ball Pressure	IEC 60695-10-2	С	-	-
ISO Heat Deflection (1.80 MPa)	ISO 75-2	С	-	-
ISO Tensile Strength	ISO 527-2	MPa	-	-
ISO Flexural Strength	ISO 178	MPa	-	-
ISO Tensile Impact	ISO 8256	kJ/m ²	-	-
ISO Izod Impact	ISO 180	kJ/m ²	-	-
ISO Charpy Impact	ISO 179-2	kJ/m ²	-	-

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Test Report

華立企業股份有限公司 WAH LEE INDUSTRIAL CORP. 台北市復興北路369號11樓

11F, NO. 369, FU-HSING N. ROAD, TAIPEI, 105 TAIWAN, R. O. C.

號碼(No.): CE/2016/43083 日期(Date): 2016/04/21 頁數(Page): 1 of 13

以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

送樣廠商(Sample Submitted Bv) SUMITOMO CHEMICAL CO., LTD. 樣品名稱(Sample Description) SUMIKASUPER LCP RESIN

樣品型號(Style/Item No.) SUMIKASUPER E6006LMRB & E4008MRB & E6008MRB & E5008LB & E5006LB &

E6807LHFBZ & E6808UHFBZ & E6808LHFBZ & E6007LHFBZ & E6810LHFBZ &

E6810GHFBZ & E6810KHFBZ & E6810MRB & SZ6505HFB & SZ6506HFB & E6809CHFBZ & E6208LHFBZ & SV6808THFB & SV6808GHFB & SV6807B & E6807TB & SR2506B &

SZ4506B & SV6808LB

收件日期(Sample Receiving Date) 2016/04/15

2016/04/15 TO 2016/04/21 測試期間(Testing Period)

測試需求(Test Requested):

(1)依據客戶指定,參考RoHS2011/65/EU Annex II及其修訂指令(EU) 2015/863測試編、鉛、汞、六價鉻、多溴聯苯、多溴聯苯 醚, DBP, BBP, DEHP, DIBP. (As specified by client, with reference to RoHS 2011/65/EU Annex II and amending Directive (EU) 2015/863 to determine Cadmium, Lead, Mercury, Cr(VI), PBBs, PBDEs, DBP, DEHP, DIBP contents in the submitted sample.)

(2) 其他測試項目請見下一頁 . (Please refer to next pages for the other item(s).)

請見下一頁 (Please refer to next pages). 測試結果(Test Results) :



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11F, NO. 369, FU-HSING N. ROAD, TAIPEI, 105 TAIWAN, R. O. C.

測試結果(Test Results)

測試部位(PART NAME)No.1 : 黑色塑膠粒 (BLACK PLASTIC PELLETS)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限值	結果 (Result)
(lest Items)	(UIII t)	(method)	(MDL)	No. 1
鎬 / Cadmium (Cd)	mg/kg	参考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.
鉛 / Lead (Pb)	mg/kg	參考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321-4 (2013),以感應耦合電漿原子發射光譜儀檢測. / With reference to IEC 62321-4 (2013) and performed by ICP-AES.	2	n. d.
六價鉻 / Hexavalent Chromium Cr(VI)	mg/kg	参考IEC 62321 (2008),以UV-VIS檢 測. / With reference to IEC 62321 (2008) and performed by UV-VIS.	2	n. d.
銻 / Antimony (Sb)	mg/kg	參考US EPA 3050B (1996),以感應耦合電漿原子發射光譜儀檢測. / With reference to US EPA 3050B (1996). Analysis was performed by ICP-AES.	2	n. d.
三氧化二锑 / Antimony trioxide (Sb ₂ 0 ₃)*** (CAS No.: 1309-64-4)	mg/kg	参考US EPA 3050B (1996),以感應耦合電漿原子發射光譜儀檢測. / With reference to US EPA 3050B (1996). Analysis was performed by ICP-AES.***	-	n. d.



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11F, NO. 369, FU-HSING N. ROAD, TAIPEI, 105 TAIWAN, R. O. C.

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result)
六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α – HBCDD, β – HBCDD, γ – HBCDD) (CAS No.: 25637–99–4 and 3194–55–6 (134237–51–7, 134237–50–6, 134237–52–8))	mg/kg	參考IEC 62321 (2008),以氣相層析/ 質譜儀檢測. / With reference to IEC 62321 (2008). Analysis was performed by GC/MS.	5	n. d.
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	mg/kg		50	n. d.
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n. d.
郷苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761- 40-0; 68515-49-1)	mg/kg		50	n. d.
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553- 12-0; 68515-48-0)	mg/kg	參考IEC 62321-8/CD (2013),以氣相層析儀/質譜儀檢測. / With reference to IEC 62321-8/CD (2013). Analysis was performed by GC/MS.	50	n. d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n-octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.
鄰苯二甲酸二異丁酯 / DIBP (Di- isobutyl phthalate) (CAS No.: 84-69- 5)	mg/kg		50	n. d.
鄰苯二甲酸二戊酯 / Di-n-pentyl phthalate (CAS No.: 131-18-0)	mg/kg		50	n. d.
鄰苯二甲酸二正己酯 / DNHP (Di-n-hexyl phthalate) (CAS No.: 84-75-3)	mg/kg		50	n. d.
鄰苯二甲酸二 (2-甲氧基乙基)酯 / DMEP (Bis (2-methoxyethyl) phthalate) (CAS No.: 117-82-8)	mg/kg		50	n. d.



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11F, NO. 369, FU-HSING N. ROAD, TAIPEI, 105 TAIWAN, R. O. C.

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result) No.1
全氟辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	參考US EPA 3550C (2007),以液相層析/質譜儀檢測. / With reference to US EPA 3550C (2007). Analysis was performed by LC/MS.	10	n. d.
全氟辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	参考US EPA 3550C (2007),以液相層析/質譜儀檢測. / With reference to US EPA 3550C (2007). Analysis was performed by LC/MS.	10	n. d.
多溴聯苯總和 / Sum of PBBs	mg/kg		_	n. d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n. d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n. d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.
七溴聯苯 / Heptabromobiphenyl	mg/kg		5	n. d.
八溴聯苯 / Octabromobiphenyl	mg/kg		5	n. d.
九溴聯苯 / Nonabromobiphenyl	mg/kg	参考IEC 62321-6 (2015),以氣相層析	5	n. d.
十溴聯苯 / Decabromobiphenyl	mg/kg	/質譜儀檢測. / With reference to	5	n. d.
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	IEC 62321-6 (2015) and performed	-	n. d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	by GC/MS.	5	n. d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n. d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n. d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n. d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n. d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg]	5	n. d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg]	5	n. d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg]	5	n. d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg]	5	n. d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	n. d.



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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result)
(Test Items)				No. 1
鹵素 / Halogen				
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	268
鹵素(氣)/ Halogen-Chlorine (C1) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582 (2007),以離子層析 儀分析. / With reference to BS EN	50	n. d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	14582 (2007). Analysis was performed by IC.	50	n. d.
鹵素(碘)/ Halogen-Iodine(I)(CAS No.: 14362-44-8)	mg/kg		50	n. d.

日期(Date): 2016/04/21

備註(Note):

- 1. mg/kg = ppm ; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限值)
- 4. "-" = Not Regulated (無規格值)
- 5. ***: 該物質是由銻之測試結果計算得知. 其MDL是針對銻之評估. (The substance was calculated by the test results of Antimony. The MDL was evaluated for Antimony.)
- 6. 參數換算表 / Parameter Conversion Table: Please refer to http://twap.sgs.com/sgsrsts/chn/download-REACH_tw.asp

PFOS参考資訊(Reference Information): 持久性有機污染物 POPs - (EU) 757/2010

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗 層材料中不得超過1µg/m2。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above $1\mu g/m^2$.)



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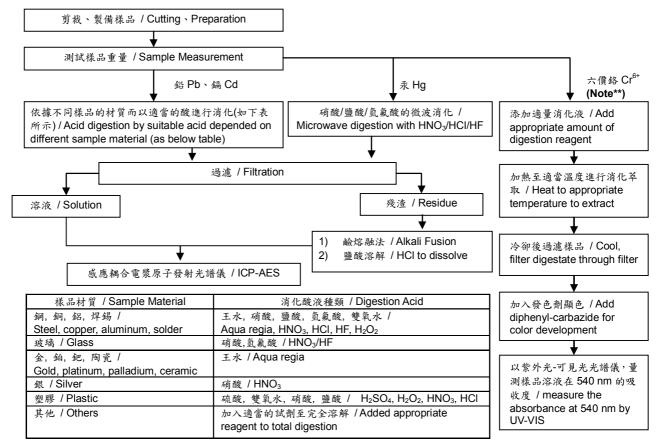
根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外)

號碼(No.): CE/2016/43083

These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr⁶⁺ test method excluded)

日期(Date): 2016/04/21

- 測試人員:楊登偉 / Technician: Climbgreat Yang
- 測試負責人:張啟興 / Supervisor: Troy Chang



Note** (For IEC 62321)

- (1) 針對非金屬材料加入鹼性消化液,加熱至 90~95℃ 萃取. / For non-metallic material, add alkaline digestion reagent and heat to 90~95℃
- (2) 針對金屬材料加入純水,加熱至沸騰萃取. / For metallic material, add pure water and heat to boiling.



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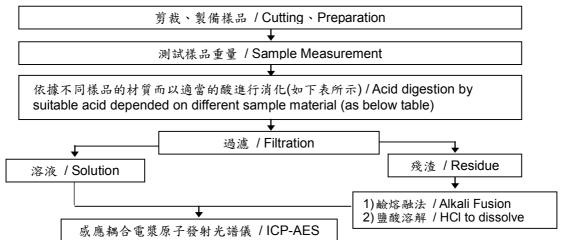
根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

測試人員:楊登偉 / Technician: Climbgreat Yang

號碼(No.): CE/2016/43083

測試負責人:張啟興 / Supervisor: Troy Chang

元素以 ICP-AES 分析的消化流程圖 (Flow Chart of digestion for the elements analysis performed by ICP-AES)



鋼,銅,鋁,焊錫 / Steel, copper, aluminum, solder	王水,硝酸,鹽酸,氫氟酸,雙氧水 / Aqua regia, HNO ₃ , HCl, HF, H ₂ O ₂
玻璃 / Glass	硝酸,氫氟酸 / HNO ₃ /HF
金,鉑,鈀,陶瓷 / Gold, platinum, palladium, ceramic	王水 / Aqua regia
銀 / Silver	硝酸 / HNO ₃
塑膠 / Plastic	硫酸,雙氧水,硝酸,鹽酸 / H ₂ SO ₄ , H ₂ O ₂ , HNO ₃ , HCI
其他 / Others	加入適當的試劑至完全溶解 / Added appropriate reagent to total digestion



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號碼(No.): CE/2016/43083

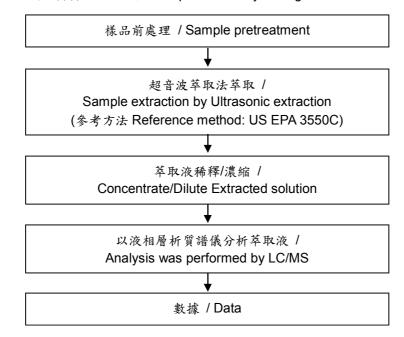
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全氟辛酸/全氟辛烷磺酸分析流程圖 / Analytical flow chart - PFOA/PFOS

日期(Date): 2016/04/21

測試人員: 翁賜彬 / Technician: Roman Wong

測試負責人:張啟興 / Supervisor: Troy Chang





測試報告 **Test Report**

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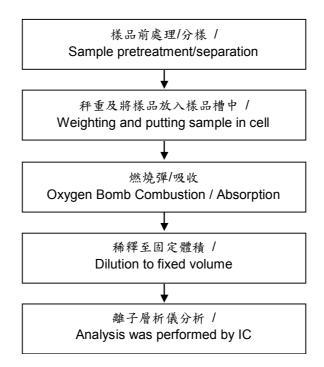
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號碼(No.): CE/2016/43083 日期(Date): 2016/04/21 頁數(Page): 9 of 13

鹵素分析流程圖 / Analytical flow chart - Halogen

測試人員: 陳恩臻 / Technician: Rita Chen

測試負責人:張啟興 / Supervisor: Troy Chang





Test Report 華立企業股份有限公司 WAH LEE INDUSTRIAL CORP.

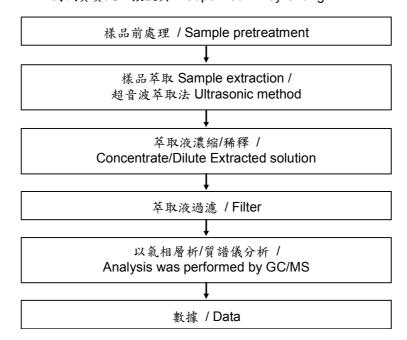
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六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

測試人員: 翁賜彬 / Technician: Roman Wong 測試負責人:張啟興 / Supervisor: Troy Chang





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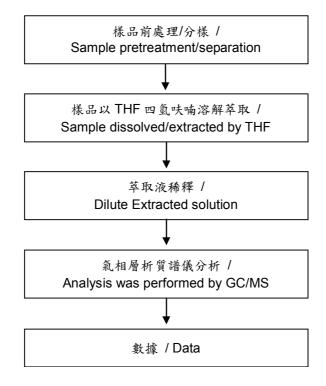
號碼(No.): CE/2016/43083 日期(Date): 2016/04/21 頁數(Page): 11 of 13

可塑劑分析流程圖 / Analytical flow chart - Phthalate

測試人員:徐毓明 / Technician: Andy Shu

測試負責人:張啟興 / Supervisor nt: Troy Chang

【測試方法/Test method: IEC 62321-8】





測試報告

Test Report

華立企業股份有限公司 WAH LEE INDUSTRIAL CORP. 台北市復興北路369號11樓 11F, NO. 369, FU-HSING N. ROAD, TAIPEI, 105 TAIWAN, R. O. C.

號碼(No.): CE/2016/43083

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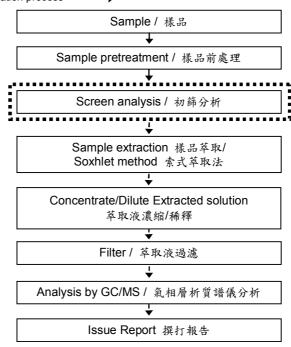
多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

日期(Date): 2016/04/21

測試人員: 翁賜彬 / Technician: Roman Wong

測試負責人:張啟興 / Supervisor: Troy Chang

初次測試程序 / First testing process . 選擇性篩檢程序 / Optional screen process •••••• 確認程序 / Confirmation process - - - →



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* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)

CE/2016/43083



** 報告結尾 (End of Report) **

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INSPECTION CERTIFICATE according to EN10204 3.1

Our Reference:Certificate No:Date:Shipping Zutphen13 0545319-09-2013

Customer:

AURUBIS AHE MATERIAL D.C.

(Shanghai) Co.Ltd.Section A 1th Fl. No.211 Fute Road Waigaoqiao Free Trade Zone 200131 SHANGHAI China.

 Description:
 BRSTRP 305 X 0.15 MM
 Order No:
 378759 / 1

 Order No/Ref:
 PO000366B
 Alloy - Temper:
 1065 - 95

Mark: Norm Specification:

 Part No:
 Our part no:
 768719

 Net weight:
 911 kg

CHEMICAL COMPOSITION

	Coil	Cu	Zn
		min/max	min/max
Specified values:		64,5 / 66,5	33,5 / 35,5
Actual values:	214524	65,7 / 66,0	Remainder

DIMENSIONAL REQUIREMENTS

	Coil	Thickness				Width
		min/max				min/max
		mm	Х	s	n	mm
Specified values:		0,143 / 0,157				304,85 /
						305,15
Actual values:	214524	0,147 / 0,154	0,149	0,0013	794	304,98 /
						304,98

MECHANICAL PROPERTIES

	Coil	Hardness	Tensile
			strength
		(Vickers)	N/mm2
		min/max	min/max
Specified values:		180 / 210	565 / 635
Actual values:	214524	194 / 195	635 / 635

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Report No. ECL01I000828001R1

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Applicant

LOTES SUZHOU CO.,LTD

Address

NO.26 CAOHU AVENUE XIANGCHENG ECONOMY DEVELOPMENT ZONE

The following sample (s) and sample information was/were submitted and identified by/on the behalf of the client

Sample Name

Brass Strip

Part No.

SM1065/7

Color

Yellow

Buyer

LOTES Suzhou CO.,LTD

Supplier

Aurubis Netherlands BV

Sample Received Date

Jan. 6, 2016

Testing Period

Jan. 6, 2016 to Jan. 9, 2016

Test Requested

As specified by client, to test Lead (Pb), Cadmium (Cd), Mercury (Hg),

Hexavalent Chromium(Cr(VI)) in the submitted sample(s).

Test Method

10.4 / 10.4 /		
Test Item(s)	Test Method	Measured Equipment(s)
Lead (Pb)	IEC 62321-5:2013 Ed.1.0	ICP-OES
Cadmium (Cd)	IEC 62321-5:2013 Ed.1.0	ICP-OES
Mercury (Hg)	IEC 62321-4:2013 Ed.1.0	ICP-OES
Hexavalent Chromium(Cr(VI))	IEC 62321-7-1:2015	UV-Vis

Test Result(s)

Please refer to the following page(s).

Hongwei

Senio Laboratory Manager

Centre Sesting International Pinbiao (Shanghai) Co., Ltd.

Reviewed by

Hulfony mes

Date

Jan. 12, 2016

No. R229256700

No.1996, Xinjinqiao Road, Pudong New District, Shanghai, China

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Report No. ECL01I000828001R1

Page 2 of 4

Test Result(s)

Tested Item(s)	Result	MDL
Lead (Pb)	16 mg/kg	2 mg/kg
Cadmium (Cd)	5 mg/kg	2 mg/kg
Mercury (Hg)	N.D.	2 mg/kg
Hexavalent Chromium(Cr(VI))	N.D. (Negative)	0.02 μg/cm2

Tested Sample/Part Description

Golden metal

Remark: The sample(s) had been dissolved totally tested for Lead, Cadmium, Mercury.

-MDL = Method Detection Limit -N.D. = Not Detected (<MDL)

-mg/kg = ppm = parts per million

-Negative = Absence of Cr(VI). The Cr(VI) concentration detected in the boiling water

extraction solution is less than 0.10µg/cm²



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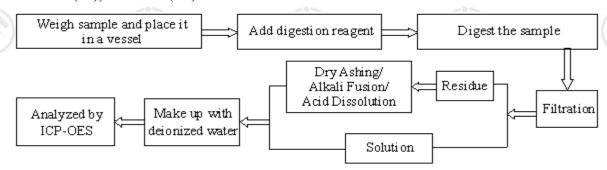


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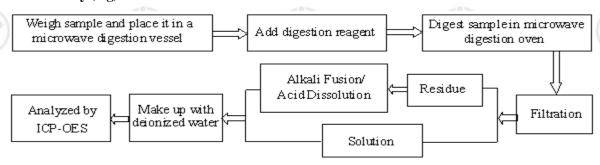
Page 3 of 4

Test Process

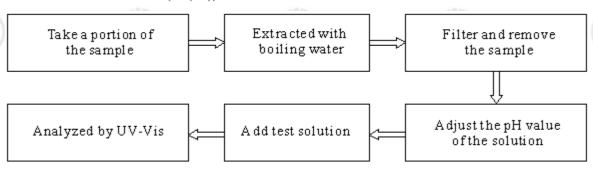
1. Lead (Pb), Cadmium (Cd)



2. Mercury (Hg)



3. Hexavalent Chromium(Cr(VI))





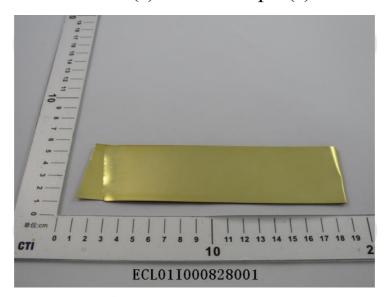




Report No. ECL01I000828001R1

Page 4 of 4

Photo(s) of the sample(s)



*** End of report ***

The test report is effective only with both signature and specialized stamp. The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CTI, this report can't be reproduced except in full.



材 質 證 明 書

昆山瑞华达精密电子材料有限公司

MATERIAL CERTIFICATE

昆山市张浦镇振新西路 300 号

Kunshan Ruihuada Precision Electronic Material Co., Ltd.

TEL: 0512-57299581 FAX: 0512-36603722

製造	編號		得意				连產編號 comer No	2011082	5002	開立日期 Issue Date	2011-8-25	證明書編號 Certificate No	201108250				
鋼種	名稱				S5	0C				童	丁單編號 der No			依據規範 By Standard	ЛS		
專案	錚	巻編號		厚度 (MM)	寬度((MM)	長度(MM)	數量	重量(H	ζ (G)	成。	品表面加工			
Item	C	oil No	,	Thick	kness	W	idth	Len	gth	Quantity	Weigh	nt	Sur	face Finish			
1				0.4	1	2	6	CO	IL	1C	样品						
2								CO	IL								
3								CO									
4								CO									
5								CO	IL								
規格				小庭 ((Thomicol	Analyza	s Wtx%)					降伏強	度引張強度			
外伯					liennear	Anarysi	18 W LX 70) 			Spec	硬度	(N/mn		伸長率(%)	彎曲試驗	
Spec	C	Si	Mn	P	S	Ni	Cr	Mo	N		Spec	Hardness	Yieldstr		Elongation	BendTest	
專案	0.47	0.15	0.60	0.030	0. 035						試片編號						
Item	0.53	0.35	0.90	max.	max.						Specimen	HV	min	min	min	min	
1	0.48	0.25	0.74	0.022	0.003						20110825002	170				OK	
2																	
3																	
4																	
5																	
以上所列出的典型資料,僅供參考,並不代表技術資料的最大或最小值,也不用於最終設計。任一具體材料的											技術部	『經理					
資料可能與此表中所列出的資料有所不同。 Data shown are typical,For reference only,and should not be construed as maximum or minimum values for specification or for							•	repancy pls contact	us within3day`s.	Mamger ,T	echnology						
		• •		•			e construe those show			or minimui	n values for specif	ication or for				Depar	tment
mai .D	ata on an	y particul	iai piece	or materi	iai iiiäy Vä	ny mom	mose snov	vii neren.									



No. SHAEC1614613901

Date: 06 Jul 2016

Page 1 of 4

Kunshan Ruihuada Precision Electronic Material Co., Ltd Vibration, ZhangPu town, Kunshan City West Road No.889

The following sample(s) was/were submitted and identified on behalf of the clients as: S50C

SGS Job No.:

SP16-024362 - SH

Model No.:

S50C

Date of Sample Received:

04 Jul 2016

Testing Period:

04 Jul 2016 - 06 Jul 2016

Test Requested:

Selected test(s) as requested by client.

Test Method:

Please refer to next page(s).

Test Results:

Please refer to next page(s).

Conclusion:

Based on the performed tests on submitted sample(s), the results of Lead,

Mercury, Cadmium, Hexavalent chromium comply with the limits as set by RoHS

Directive (EU) 2015/863 amending Annex II to Directive 2011/65/EU.

Signed for and on behalf of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd.

Marry Ma

Approved Signatory



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No. SHAEC1614613901

Date: 06 Jul 2016

Page 2 of 4

Test Results:

Test Part Description:

Specimen No. SGS Sample ID Description SN1 SHA16-146139.001 Silvery metal

Remarks:

(1) 1 mg/kg = 0.0001%

(2) MDL = Method Detection Limit

(3) ND = Not Detected (< MDL)

(4) "-" = Not Regulated

RoHS Directive (EU) 2015/863 amending Annex II to Directive 2011/65/EU

- Test Method: (1) With reference to IEC 62321-5:2013, determination of Cadmium by ICP-OES.
 - (2) With reference to IEC 62321-5:2013, determination of Lead by AAS.
 - (3) With reference to IEC 62321-4:2013, determination of Mercury by ICP-OES.
 - (4) With reference to IEC 62321:2008, determination of Hexavalent Chromium by spot test / Colorimetric Method using UV-Vis.

Test Item(s)	<u>Limit</u>	<u>Unit</u>	<u>MDL</u>	<u>001</u>
Cadmium (Cd)	100	mg/kg	2	ND
Lead (Pb)	1000	mg/kg	2	ND
Mercury (Hg)	1000	mg/kg	2	ND
Hexavalent Chromium (Cr(VI))	-	-	\Diamond	Negative

Notes:

- (1) The maximum permissible limit is quoted from RoHS Directive (EU) 2015/863.
- (2) \$Spot-test:

Negative = Absence of Cr(VI) coating, Positive = Presence of Cr(VI) coating;

(The tested sample should be further verified by boiling-water-extraction method if the spot test result is Negative or cannot be confirmed.)

Boiling-water-extraction:

Negative = Absence of Cr(VI) coating

Positive = Presence of Cr(VI) coating; the detected concentration in boiling-water-extraction solution is equal or greater than 0.02 mg/kg with 50 cm² sample surface area.

Information on storage conditions and production date of the tested sample is unavailable and thus Cr(VI) results represent status of the sample at the time of testing.



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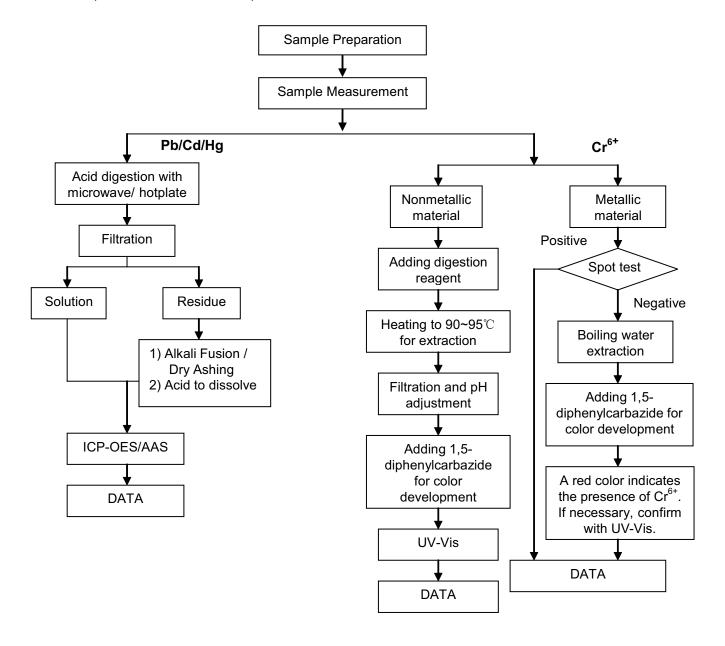
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ATTACHMENTS

RoHS Testing Flow Chart

- 1) Name of the person who made testing: Bob Zhang/Jing Zhang/Shimin Zhang
- 2) Name of the person in charge of testing: Luna Xu/Jan Shi/Stone Chen
- 3) These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr⁶⁺ test method excluded)





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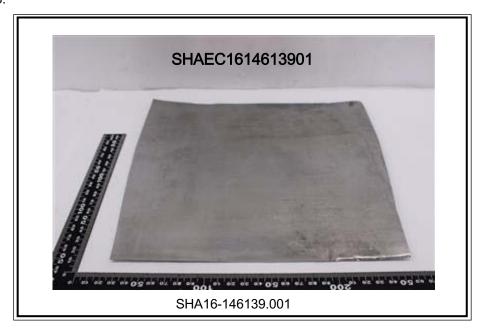


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Sample photo:



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检测报告 Test Report

报告编号 ECL01I062655002E Report No. ECL01I062655002E 第 1 页 共 6 页 Page 1 of 6

申请单位 得意精密電子(蘇州)有限公司 **Applicant** LOTES(SUZHOU) CO.,LTD

地 址 江蘇省蘇州市相城經濟開發區漕湖大道26號

Address NO.26 CAOHU ROAD XIANGCHENG ECONOMIC DEVELOPMENT ZONE, SUZHOU

CHINA

以下测试之样品及样品信息由申请者提供并确认

The following sample (s) and sample information was/were submitted and identified by/on the behalf of the client

材料名称

Material C1065

样品接收日期 2016.10.24 Sample Received Date Oct. 24, 2016

样品检测日期 2016.10.24-2016.10.27

Testing Period Oct. 24, 2016 to Oct. 27, 2016

检测要求 根据客户要求,对所提交样品中的铅(Pb),镉(Cd),汞(Hg),六价铬(Cr(Ⅵ)),

全氟辛烷磺酸盐(PFOS)进行测试。

Test Requested As specified by client, to test Lead (Pb), Cadmium (Cd), Mercury (Hg),

Hexavalent Chromium(Cr(VI)), Perfluorooctane Sulfonates(PFOS) in the

submitted sample(s).

检测依据/检测结果

请参见下页。

Test Method/Test Result(s)

Please refer to the following page(s).

主 检 方 女月女月 Tested by 方 女月女月 批 推 和 Approved by Approve

international Pintrao(Shanghai) Co., Ltd.

Reviewed by

核

日期

Date

审

陷英

2016.10.27

No. R264041685

上海市浦东新区新金桥路1996号 No.1996,Xinjinqiao Road, Pudong New District,Shanghai,China





报告编号 ECL01I062655002E Report No. ECL01I062655002E 第 2 页 共 6 页 Page 2 of 6

检测依据 Test Method

测试项目 Test Item(s)	测试方法 Test Method	测试仪器 Measured Equipment(s)
铅(Pb) Lead (Pb)	参考IEC 62321-5: 2013 Ed. 1. 0 Refer to IEC 62321-5:2013 Ed.1.0	ICP-OES
镉(Cd) Cadmium (Cd)	参考IEC 62321-5: 2013 Ed. 1. 0 Refer to IEC 62321-5:2013 Ed.1.0	ICP-OES
汞(Hg) Mercury (Hg)	参考IEC 62321-4: 2013 Ed. 1. 0 Refer to IEC 62321-4: 2013 Ed. 1. 0	ICP-OES
六价铬(Cr(VI)) Hexavalent Chromium(Cr(VI))	IEC 62321-7-1:2015	UV-Vis
全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)	参考US EPA 3550C: 2007 & US EPA 8321B: 2007 Refer to US EPA 3550C:2007 & US EPA 8321B:2007	LC-MS-MS

检测结果 Test Result(s)

测试项目 Test Item(s)	结果 Result	方法检出限 MDL
铅(Pb) Lead (Pb)	60 mg/kg	2 mg/kg
镉(Cd) Cadmium (Cd)	N.D.	2 mg/kg
汞(Hg) Mercury (Hg)	N.D.	2 mg/kg
六价铬(Cr(VI)) Hexavalent Chromium(Cr(VI))	N.D. ▼	0.10 μg/cm2(LOQ)
Mad A A TE TO THE A TO THE A TE	W = 7.	

测试项目 Test Item(s)	结果 Result	方法检出限 MDL
全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)	N.D.	0.5 μg/m²











报告编号 ECL01I062655002E Report No. ECL01I062655002E 第 3 页 共 6 页 Page 3 of 6

备注: 对于检测铅,镉,汞之样品已完全溶解。

-N.D. = 未检出 (小于方法检出限或定量限)

-mg/kg = ppm = 百万分之一

-LOQ = 定量限, 六价铬的定量限为 $0.10 \,\mu g/cm^2$ - 六价铬浓度小于 $0.10 \,\mu g/cm^2$,样品未检出六价铬。

Remark: The sample(s) had been dissolved totally tested for Lead, Cadmium, Mercury.

-MDL = Method Detection Limit

-N.D. = Not Detected (<MDL or LOQ)





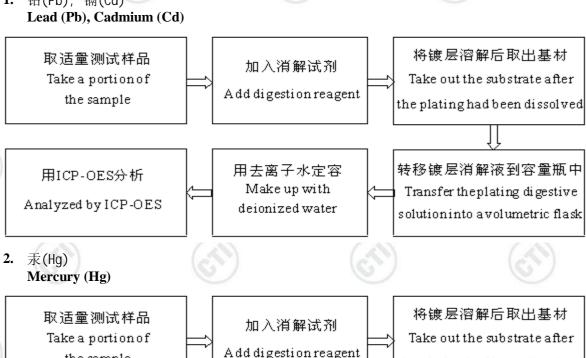


报告编号 ECL01I062655002E ECL01I062655002E Report No.

第 4 页 共 6 页 Page 4 of 6

检测流程 Test Process

铅(Pb), 镉(Cd)





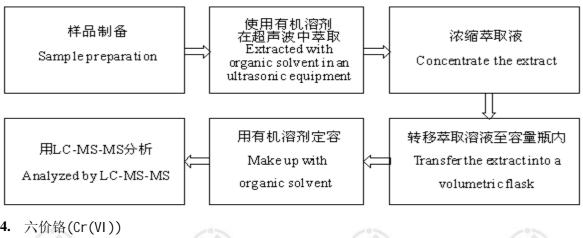




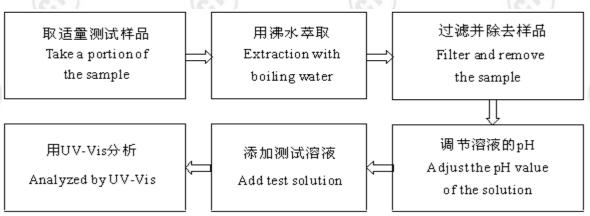
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第 5 页 共6页 Page 5 of 6

全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)



Hexavalent Chromium(Cr(VI))







检测报告 Test Report

报告编号 ECL01I062655002E Report No. ECL01I062655002E

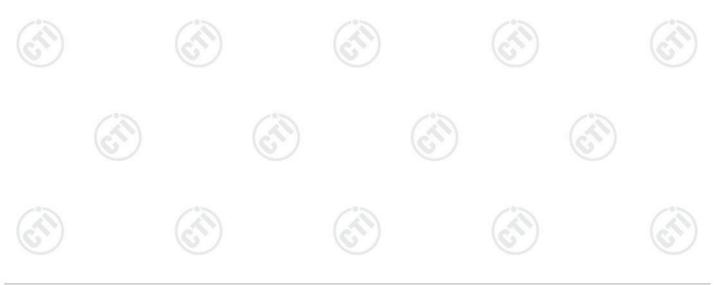
样品图片 Photo(s) of the sample(s)



报告结束 *** End of report ***

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检测报告 Test Report

报告编号 ECL01I062655001E Report No. ECL01I062655001E 第 1 页 共 6 页 Page 1 of 6

申请单位 得意精密電子(蘇州)有限公司 Applicant LOTES(SUZHOU) CO.,LTD

地 址 江蘇省蘇州市相城經濟開發區漕湖大道26號

Address NO.26 CAOHU ROAD XIANGCHENG ECONOMIC DEVELOPMENT ZONE, SUZHOU

CHINA

以下测试之样品及样品信息由申请者提供并确认

The following sample (s) and sample information was/were submitted and identified by/on the behalf of the client

样品名称

鍍層Ni Sn

Sample Name

材料名称

S50C

Material

2016.10.24 Oate Oct. 24, 2016

样品接收日期 Sample Received Date

2016.10.24-2016.10.27

样品检测日期 Testing Period

Oct. 24, 2016 to Oct. 27, 2016

检测要求

根据客户要求,对所提交样品中的铅(Pb),镉(Cd),汞(Hg),六价铬(Cr(VI)),

全氟辛烷磺酸盐(PFOS)进行测试。

Test Requested

As specified by client, to test Lead (Pb), Cadmium (Cd), Mercury (Hg), Hexavalent Chromium(Cr(VI)), Perfluorooctane Sulfonates(PFOS) in the

submitted sample(s).

检测依据/检测结果

请参见下页。

Test Method/Test Result(s)

Please refer to the following page(s).

审 核 Reviewed by

日期

Date

陷英

2016.10.27

No. R264041685

上海市浦东新区新金桥路1996号 No.1996,Xinjinqiao Road, Pudong New District,Shanghai,China





报告编号 ECL01I062655001E Report No. ECL01I062655001E 第 2 页 共 6 页 Page 2 of 6

检测依据 Test Method

测试项目 Test Item(s)	测试方法 Test Method	测试仪器 Measured Equipment(s)
铅(Pb) Lead (Pb)	参考IEC 62321-5: 2013 Ed. 1.0 Refer to IEC 62321-5:2013 Ed.1.0	ICP-OES
镉(Cd) Cadmium (Cd)	参考IEC 62321-5: 2013 Ed. 1.0 Refer to IEC 62321-5:2013 Ed.1.0	ICP-OES
汞(Hg) Mercury (Hg)	参考IEC 62321-4: 2013 Ed. 1. 0 Refer to IEC 62321-4: 2013 Ed. 1. 0	ICP-OES
六价铬(Cr(VI)) Hexavalent Chromium(Cr(VI))	IEC 62321-7-1:2015	UV-Vis
全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)	参考US EPA 3550C: 2007 & US EPA 8321B: 2007 Refer to US EPA 3550C:2007 & US EPA 8321B:2007	LC-MS-MS

检测结果 Test Result(s)

测试项目 Test Item(s)	结果 Result	方法检出限 MDL
铅(Pb) Lead (Pb)	36 mg/kg	2 mg/kg
镉(Cd) Cadmium (Cd)	N.D.	2 mg/kg
汞(Hg) Mercury (Hg)	N.D.	2 mg/kg
六价铬(Cr(VI)) Hexavalent Chromium(Cr(VI))	N.D. ▼	0.10 μg/cm2(LOQ)
NEW A DOCTOR THE AND A TOTAL OF THE ADDRESS OF THE	ALEE TO THE	

测试项目 Test Item(s)	结果 Result	方法检出限 MDL
全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)	N.D.	0.5 μg/m²













报告编号 ECL01I062655001E Report No. ECL01I062655001E

第 3 页 共 6 页 Page 3 of 6

测试样品/部位描述

银白色镀层

Tested Sample/Part Description Silver-white plating

备注: 对于检测铅,镉,汞之样品已完全溶解。

-N.D. = 未检出 (小于方法检出限或定量限)

-mg/kg = ppm = 百万分之一

-LOQ = 定量限, 六价铬的定量限为 $0.10 \,\mu g/cm^2$ - 六价铬浓度小于 $0.10 \,\mu g/cm^2$,样品未检出六价铬。

Remark: The sample(s) had been dissolved totally tested for Lead, Cadmium, Mercury.

-MDL = Method Detection Limit

-N.D. = Not Detected (<MDL or LOQ)

-mg/kg = ppm = parts per million

-LOQ = Limit of Quantification, The LOQ of Hexavalent chromium is 0.10 μg/cm2

-The sample is negative for Cr(VI) – The Cr(VI) concentration is below 0.10 $\mu g/cm^2$. The

coating is considered a non-Cr(VI) based coating.





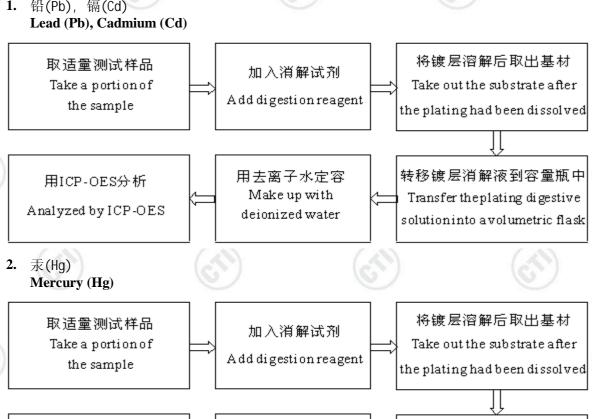


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检测流程 Test Process

铅(Pb), 镉(Cd)



用ICP-OES分析 Analyzed by ICP-OES 用去离子水定容 Make up with deionized water

转移镀层消解液到容量瓶中 Transfer the plating digestive solutioninto avolumetric flask











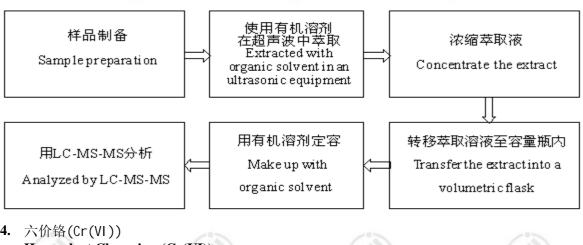




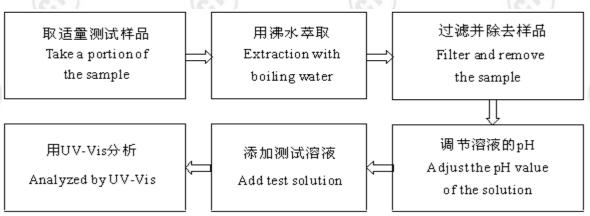
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全氟辛烷磺酸盐(PFOS) Perfluorooctane Sulfonates(PFOS)



Hexavalent Chromium(Cr(VI))



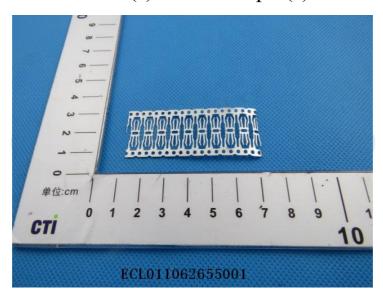




检测报告 Test Report

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样品图片 Photo(s) of the sample(s)



报告结束 *** End of report ***

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